

Application No.	Applicant(s)	
09/964,151	BOYLAN ET AL	•
Examiner	Art Unit	
John B. Vigushin	2827	1 of 2

SEARCHED			
Class	Subclass	Date	Examiner
361	91.1, 767- 771, 777- 779, 782,	7/1/2002	JBV
	783-785,		-
_	790, 791,		
	803		
257	664, 691,	7/1/2002	JBV
	698, 700,		
	723, 724,		
	728, 786		
333	33, 247	7/1/2002	JBV
324	765	7/1/2002	JBV
363	144, 146,	7/1/2002	JBV
	147		
Search	Updated	3/4/2003	JBV
Search	Updated	12/5/2003	JBV

INTERFERENCE SEARCHED			
Subclass	Date	Examiner	
767, 772,	4/1/2004	JBV	
782, 783			
<u> </u>			
	Subclass 767, 772,	Subclass Date 767, 772, 4/1/2004	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST Text Search (see print-out)	7/1/2002	JBV
EAST Text Search (see print-out)	3/4/2003	JBV
EAST Text Search (see print-out); includes text search for teachings that pin sockets are a source of circuit noise.	12/5/2003	JBV
EAST Text Search (see print-out)	4/1/2004	JBV

Search	Notes ((continued)
	<u> </u>	11 1 [1]

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09/964,151	BOYLAN ET AL.	
Examiner	Art Unit	
John B. Vigushin	2827 2 of 2	

SEARCHED				
Class	Subclass	Date	Examiner	
361	772	4/1/2004	JBV	

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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